

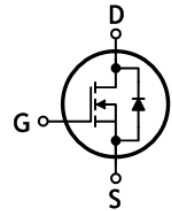
## SWITCHING REGULATOR APPLICATION

### Features

- Drain-Source breakdown voltage:  $V_{DSS}=900V$
- Low gate charge:  $Q_g=52nC$  (Typ.)
- Low drain-source On resistance:  $R_{DS(on)}=1.4\Omega$  (Max.)
- RoHS compliant device
- 100% avalanche tested

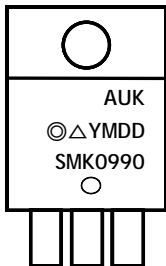
### Ordering Information

Part Number	Marking	Package
SMK0990FD	SMK0990	TO-220F-3L



TO-220F-3L

### Marking Information



Column 1: Manufacturer  
 Column 2: Production Information

e.g.) ◎△YMDD

-. ◎: **Management Code (H: Halogen Free)**

-. △: **Factory Management Code**

-. YMDD: **Date Code (Year, Month, Daily)**

Column 3: Device Code

### Absolute maximum ratings ( $T_C=25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit	
Drain-source voltage	$V_{DSS}$	900	V	
Gate-source voltage	$V_{GSS}$	$\pm 30$	V	
Drain current (DC) *	$I_D$	$T_C=25^\circ C$	9	A
		$T_C=100^\circ C$	5.7	A
Drain current (Pulsed) *	$I_{DM}$	36	A	
Single pulsed avalanche energy <sup>(Note 2)</sup>	$E_{AS}$	900	mJ	
Repetitive avalanche current <sup>(Note 1)</sup>	$I_{AR}$	9	A	
Repetitive avalanche energy <sup>(Note 1)</sup>	$E_{AR}$	4.8	mJ	
Power dissipation	$P_D$	48	W	
Junction temperature	$T_J$	150	$^\circ C$	
Storage temperature range	$T_{stg}$	-55~150	$^\circ C$	

\* Limited only maximum junction temperature

## Thermal Characteristics

Characteristic	Symbol	Rating	Unit
Thermal resistance, junction to case	$R_{th(j-c)}$	Max. 2.6	°C/W
Thermal resistance, junction to ambient	$R_{th(j-a)}$	Max. 62.5	

## Electrical Characteristics ( $T_c=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$BV_{DSS}$	$I_D=250\mu\text{A}$ , $V_{GS}=0$	900	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$I_D=250\mu\text{A}$ , $V_{DS}=V_{GS}$	3	-	5	V
Drain-source cut-off current	$I_{DSS}$	$V_{DS}=900\text{V}$ , $V_{GS}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{DS}=720\text{V}$ , $T_c=125^\circ\text{C}$	-	-	100	$\mu\text{A}$
Gate leakage current	$I_{GSS}$	$V_{DS}=0\text{V}$ , $V_{GS}=\pm 30\text{V}$	-	-	$\pm 100$	nA
Drain-source on-resistance	$R_{DS(ON)}$	$V_{GS}=10\text{V}$ , $I_D=4.5\text{A}$	-	1.2	1.4	$\Omega$
Forward transfer conductance (Note 3)	$g_{fs}$	$V_{DS}=10\text{V}$ , $I_D=4.5\text{A}$	-	9.2	-	S
Input capacitance	$C_{iss}$	$V_{DS}=25\text{V}$ , $V_{GS}=0\text{V}$ , $f=1.0\text{MHz}$	-	2100	-	pF
Output capacitance	$C_{oss}$		-	175	-	
Reverse transfer capacitance	$C_{rss}$		-	14	-	
Turn-on delay time (Note 3,4)	$t_{d(on)}$	$V_{DD}=450\text{V}$ , $I_D=9\text{A}$ , $R_G=25\Omega$	-	50	-	ns
Rise time (Note 3,4)	$t_r$		-	120	-	
Turn-off delay time (Note 3,4)	$t_{d(off)}$		-	100	-	
Fall time (Note 3,4)	$t_f$		-	75	-	
Total gate charge (Note 3,4)	$Q_g$	$V_{DS}=720\text{V}$ , $V_{GS}=10\text{V}$ , $I_D=9\text{A}$	-	52	68	nC
Gate-source charge (Note 3,4)	$Q_{gs}$		-	16	-	
Gate-drain charge (Note 3,4)	$Q_{gd}$		-	20	-	

## Source-Drain Diode Ratings and Characteristics ( $T_c=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	$I_S$	Integral reverse diode in the MOSFET	-	-	9	A
Source current (Pulsed)	$I_{SM}$		-	-	36	A
Forward voltage	$V_{SD}$	$V_{GS}=0\text{V}$ , $I_S=9\text{A}$	-	-	1.4	V
Reverse recovery time (Note 3,4)	$t_{rr}$	$I_S=9\text{A}$ , $V_{GS}=0\text{V}$ $di_F/dt=100\text{A}/\mu\text{s}$	-	550	-	ns
Reverse recovery charge (Note 3,4)	$Q_{rr}$		-	6.5	-	$\mu\text{C}$

Note:

1. Repeated rating: Pulse width limited by safe operating area
2.  $L=21\text{mH}$ ,  $I_{AS}=9\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3. Pulse test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
4. Essentially independent of operating temperature typical characteristics

## Typical Characteristics Curve

Fig. 1  $I_D - V_{DS}$

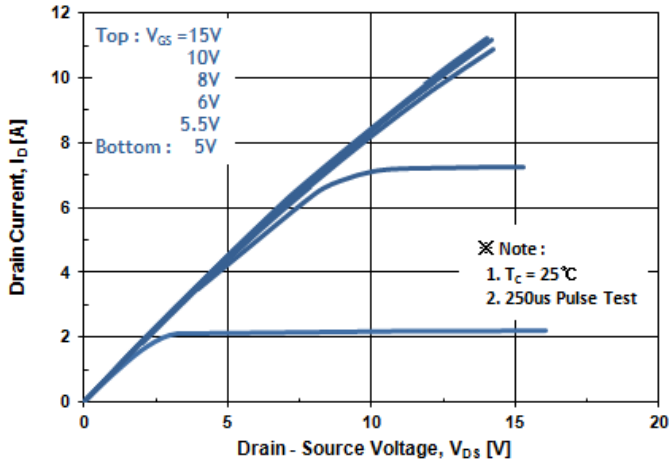


Fig. 2  $I_D - V_{GS}$

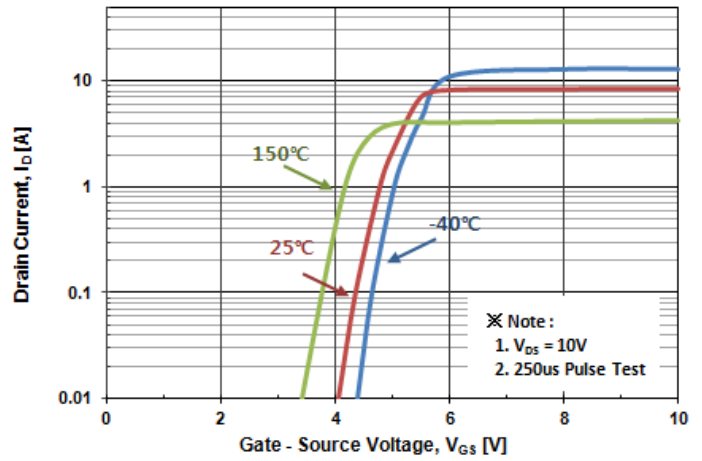


Fig. 3  $R_{DS(ON)} - I_D$

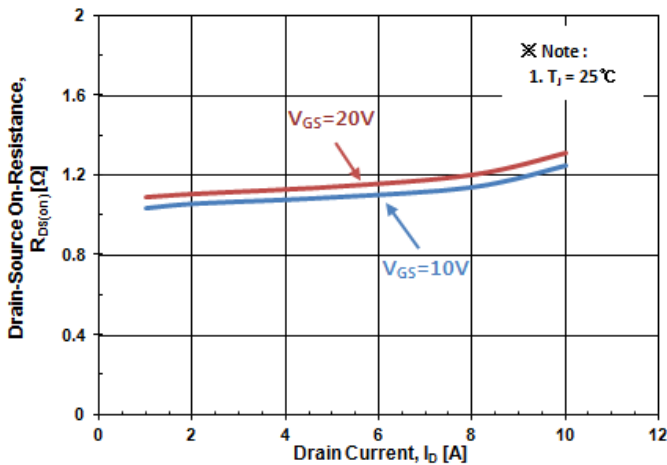


Fig. 4  $I_S - V_{SD}$

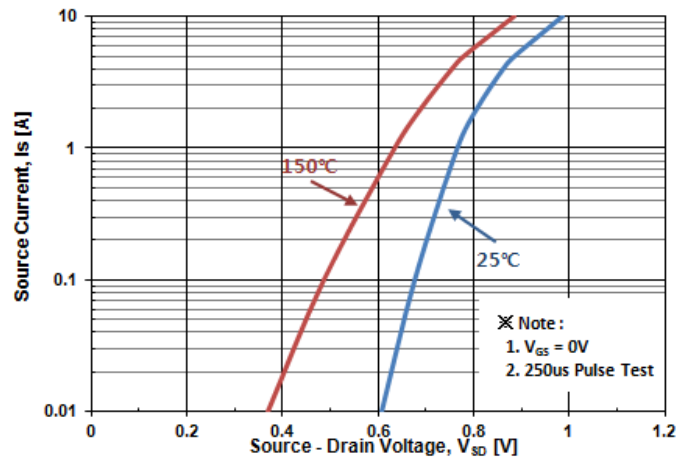


Fig. 5 Capacitance -  $V_{DS}$

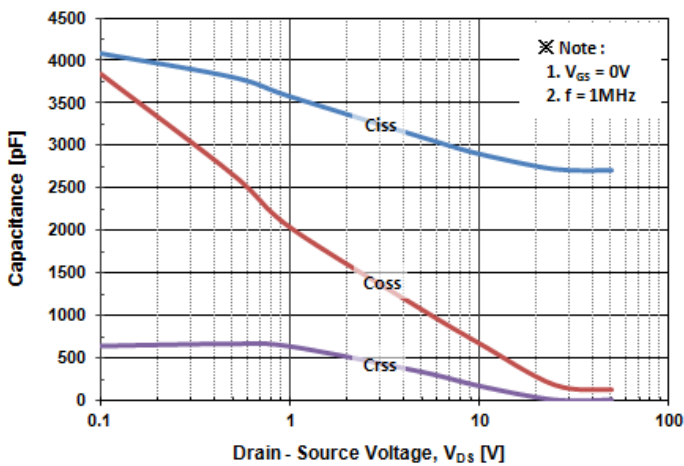
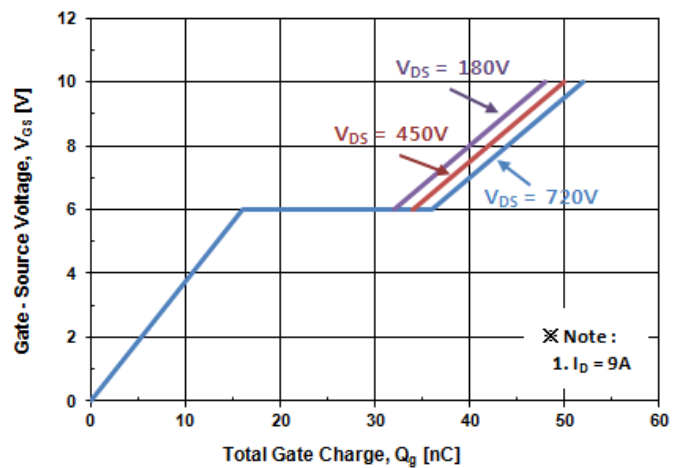


Fig. 6  $V_{GS} - Q_G$



Typical Characteristics Curve (Continue)

Fig. 7  $BV_{DSS} - T_J$

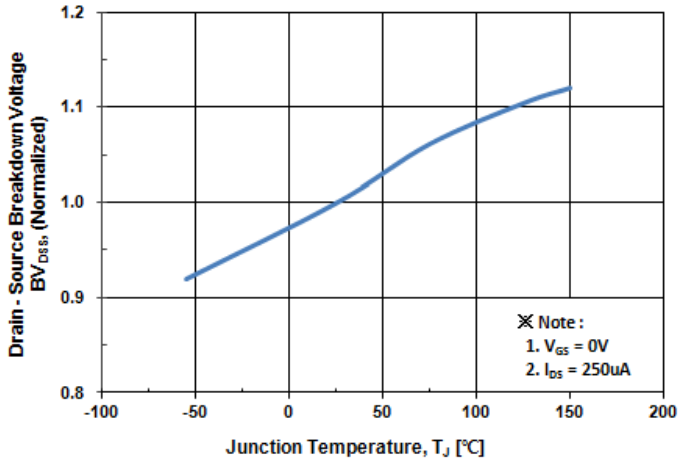


Fig. 8  $R_{DS(ON)} - T_J$

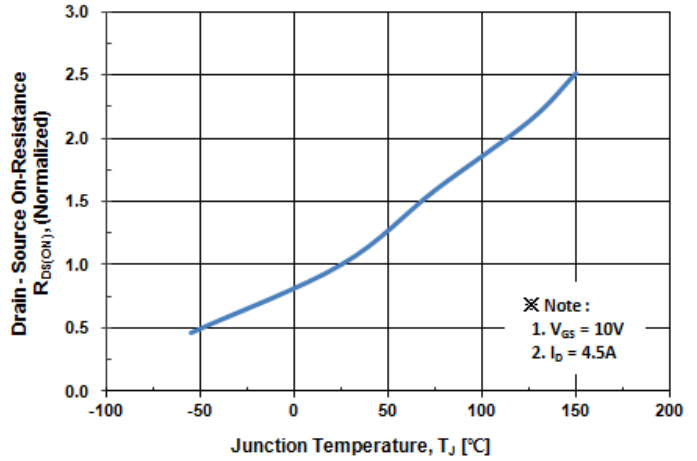


Fig. 9  $I_D - T_C$

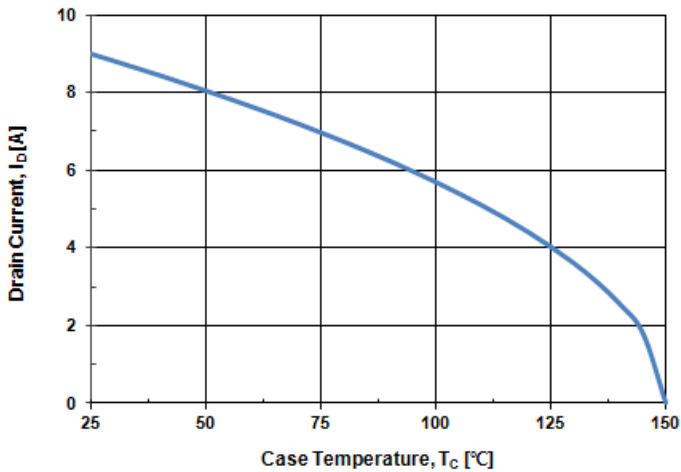


Fig. 10 Safe Operating Area

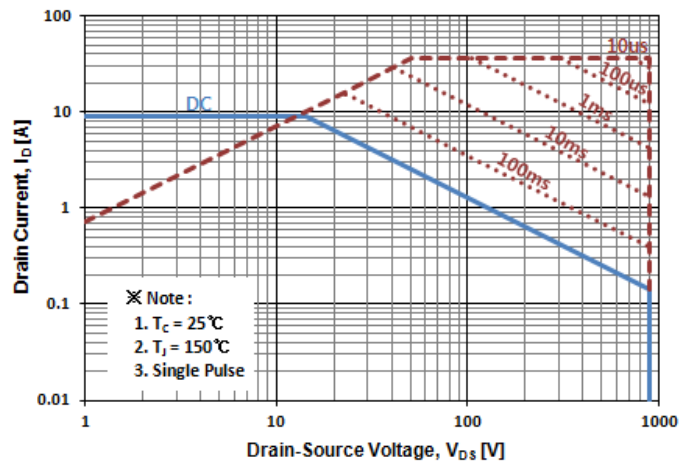


Fig. 11 Transient Thermal Impedance

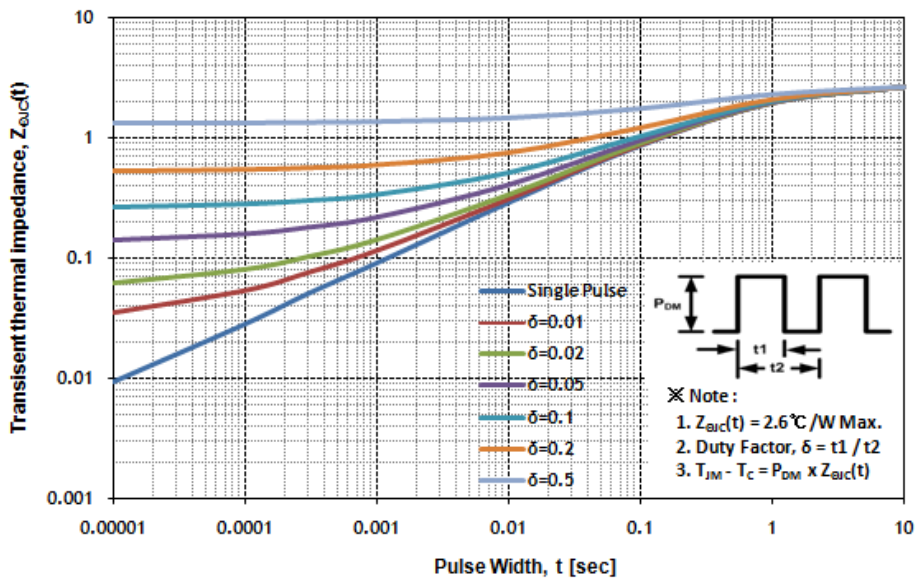


Fig. 12 Gate Charge Test Circuit & Waveform

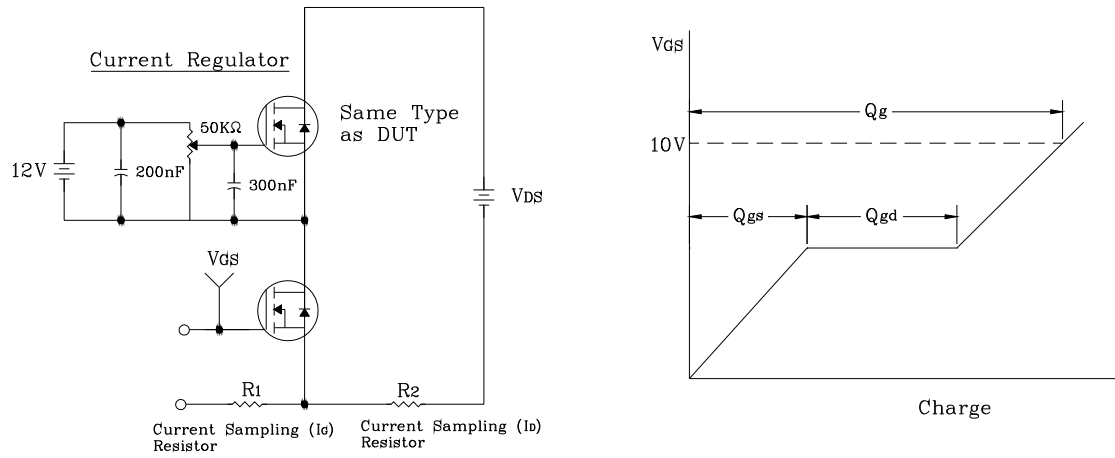


Fig. 13 Resistive Switching Test Circuit & Waveform

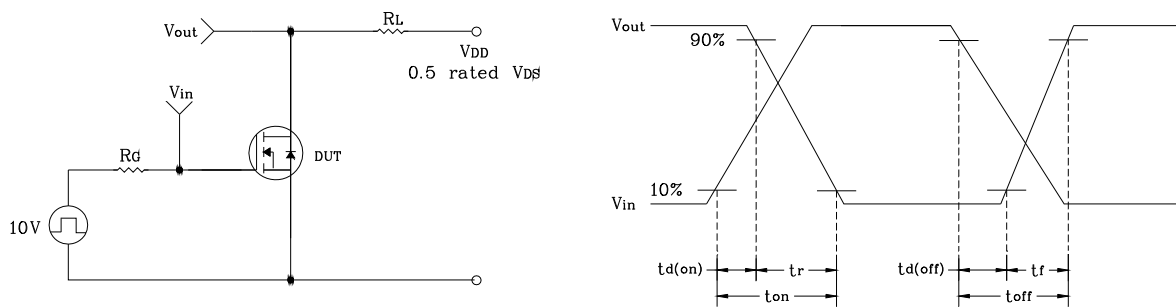


Fig. 14  $E_{AS}$  Test Circuit & Waveform

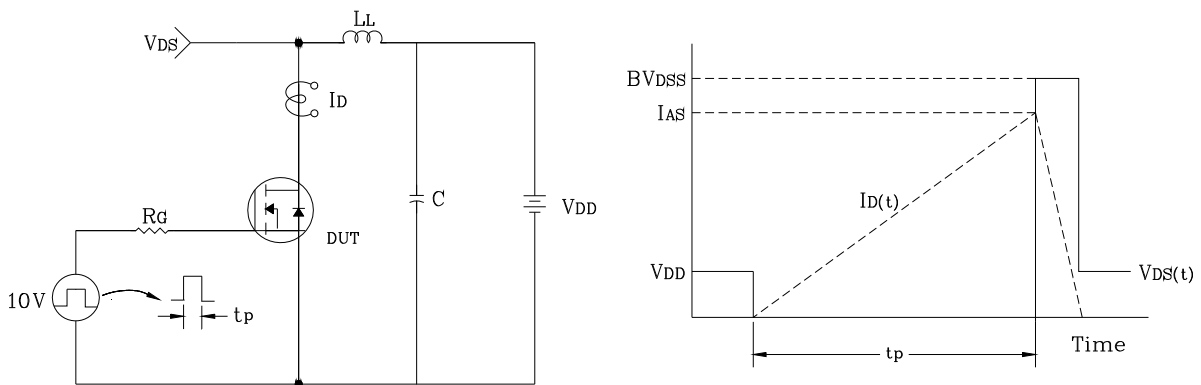
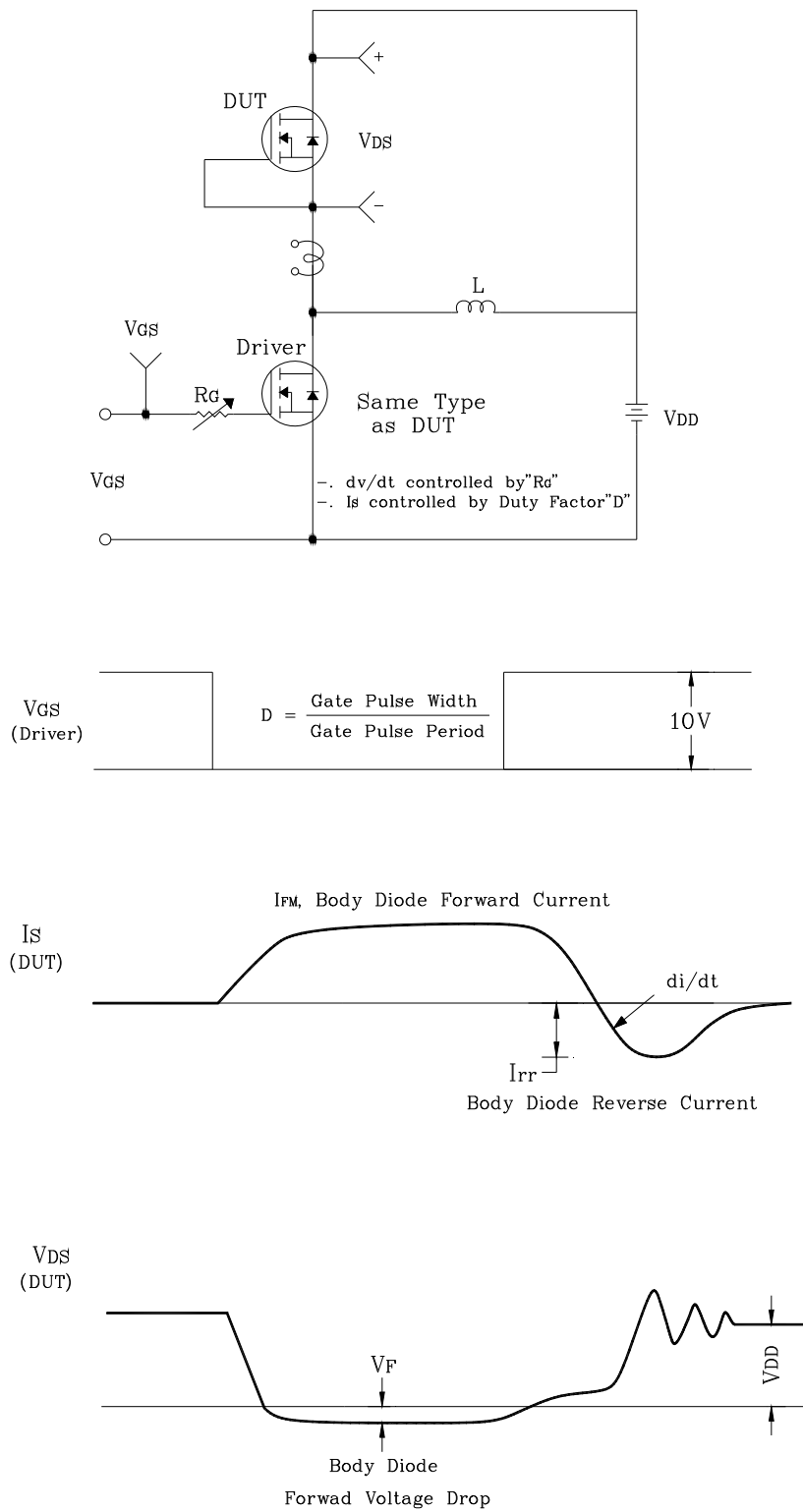
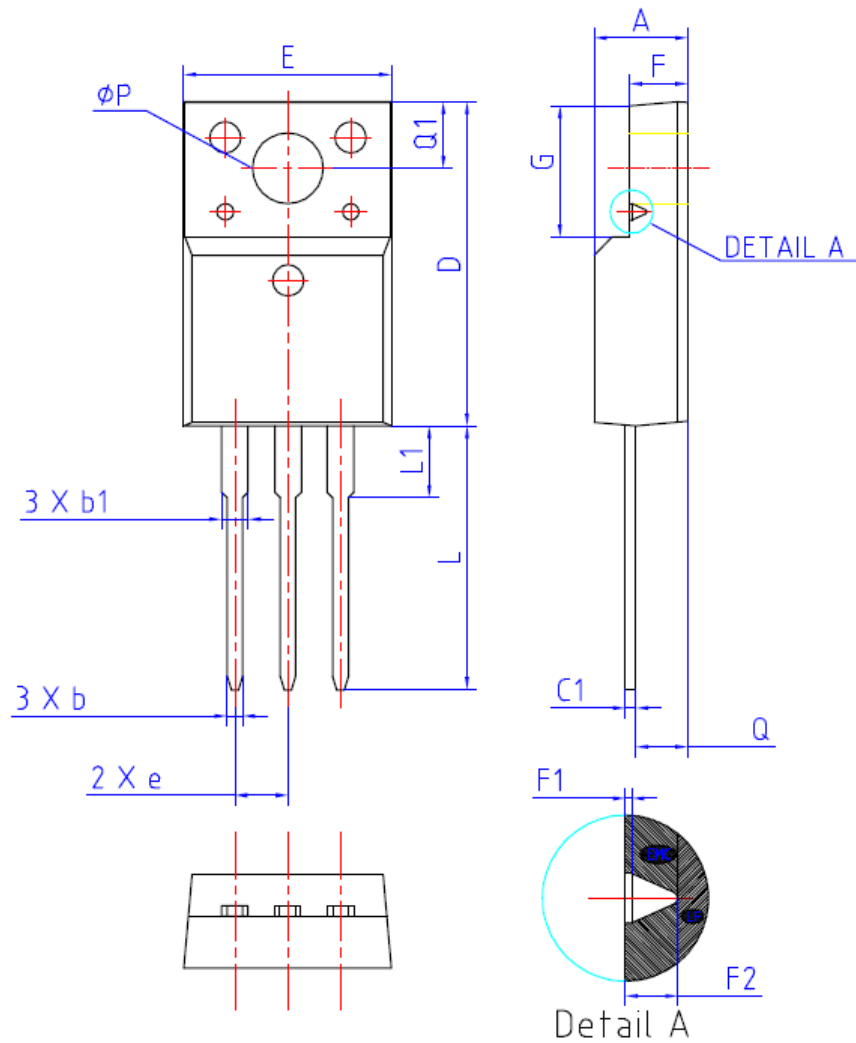


Fig. 15 Diode Reverse Recovery Time Test Circuit & Waveform



## Package Outline Dimensions



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	4.50	4.70	4.90	
b	0.70	0.80	0.90	
b1	1.33	1.40	1.47	
C1	0.45	0.50	0.60	
D	15.67	15.87	16.07	
E	9.96	10.16	10.36	
e	2.54BSC			
F	2.34	2.54	2.74	
F1	(0.10 REF)			
F2	(0.84 REF)			
G	6.48	6.68	6.88	
L	12.78	12.98	13.18	
L1	3.03	3.23	3.43	
Q	2.56	2.76	2.96	
Q1	3.10	3.30	3.50	
phi P	3.08	3.18	3.28	

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